

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10757222	KAEWELL ET AL.
	<b>Examiner</b>	<b>Art Unit</b>
	Chen, Junpeng	2618

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
455	574,572	07/18/2007	J.C.
370	311	07/18/2007	J.C.
455	13.4,522,572-574,127.1-127.5,343.1-343.6	11/6/2008	J.C.
370	311	11/6/2008	J.C.
455	13.4,522,572-574,127.1-127.5,343.1-343.6	11/7/2009	JC
370	311,321-325	11/7/2009	JC

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
EAST Image and keyword search in USPAT, US-PGPub, DERWENT, EPO, JPO and IBM_TDB	11/6/2008	J.C.
Consulted with Quochien Young (455/572,574 and 370/311)	07/18/2007	J.C.
Reconsidered the rejection in view of argument and amendment	5/15/2008	J.C.
Reconsidered the rejection in view of argument and amendment	5/10/2009	JC

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>

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